Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10521779	KOMIYA ET AL.
Examiner	Art Unit
Thomas, Mia M	2624

SEARCHED				
Subclass	Date	Examiner		

SEARCH NOTES				
Search Notes	Date	Examiner		
Author/Inventor Searchsee attached search history	09/18/07	mmt		
382/100, 154,16image, text and keyword searchsee attached search history2	09/19/07	mmt		
433/29,167image, text and keyword searchsee attached search history	09/19/07	mmt		
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Consulted W. Chen (AU 2624)	09/25/07	mmt		
Consulted B. Werner (AU 2624)	09/26/07	mmt		
Updated searchsee attached search history382/100, 162, 154433/29,167348/207.99	05/13/08	mmt		
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